

Search Notes

Application/Control No.

10/533,354

Examiner

Hau V. Phan

Applicant(s)/Patent under
Reexamination

ELLENRIEDER ET AL.

Art Unit

3618

SEARCHED

Class	Subclass	Date	Examiner
280	735 734 730.1	12/16/2007	HP
	806		
	777		
296	35.2	12/16/2007	HP
	68.1		
327	552	12/16/2007	HP
	105		
	350		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR